Machine Learning Concepts

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Basic definitions & concepts

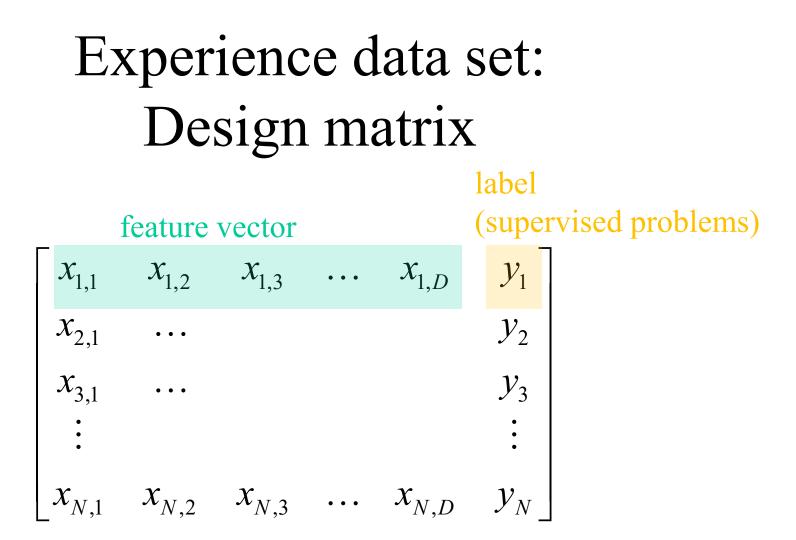
- Task What the system is supposed to do
 e.g. ASR: f(input speech) → list of words
- Performance measure How well does it work?
- Experience How does the machine learn the task?



Types of experiences; how a learner learns...

- Supervised learning Learn class conditional distributions: implies class labels are known P(ω|x) : probability of class ω given evidence x
- Unsupervised learning No labels are provided, learn P(x) and possibly group x's into clusters
- Reinforcement learning Learner actions are associated with payouts for actions in environment.





Learning sets of functions may be used if some features are missing. E.g. fn f_0 for all features, f_1 if feature 1 is missing, etc.



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A Cardinal Rule

OF MACHINE LEARNING

THOU SHALT NOT TEST ON THY TRAINING DATA

Performance

- A metric that measures how well a learner is able to accomplish the task
- Metrics can vary significantly (more on these later), examples:
 - loss functions such as squared error
 - cross entropy



Partitioning data

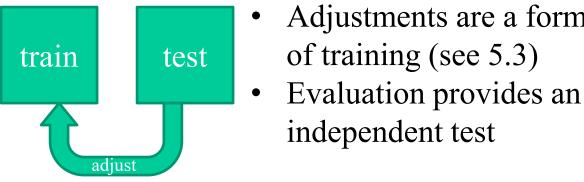
- Training data experience for learner
- Test data performance measurement
- Evaluation data
 - Only used once all adjustments are made

Adjustments are a form

of training (see 5.3)

independent test

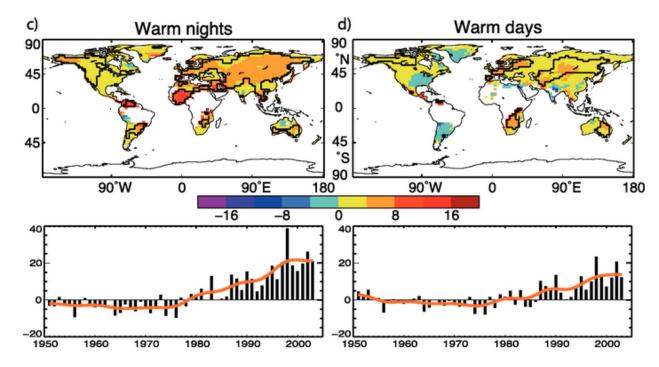
– It is common to:



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Regression

Given a set of features and response, predict a response



IPCC 4th Assessment Report Climate Change 2007

Observed changes in number of warm days/night with extreme temperatures (normative 1961-1990)



Linear regression A simple learning algorithm

Predict response from data

$$\hat{y} = w^T x$$
 $w, x \in \mathfrak{R}^N, \hat{y} \in \mathfrak{R}$

- *w* is the weight vector
- Goal: Maximize performance on test set. Learn *w* to minimize some criterion, e.g. mean squared error (MSE)

$$MSE_{\text{test}} = \frac{1}{m} \sum_{i=1}^{m} (\hat{y}_i - y_i)^2 \equiv \frac{1}{m} \|\hat{y}^{\text{test}} - y^{\text{test}}\|_2^2$$



$$\|x\|_p$$
 denotes the L^p norm $\left(\sum_i |x_i|^p\right)^{\bigvee_p}$ read Goodfellow et al. 2.5

- Cannot estimate *w* from test data
- Use the training data
- Minimize



$$MSE_{\text{train}} = \frac{1}{m} \sum_{i=1}^{m} (\hat{y}_i - y_i)^2 \equiv \frac{1}{m} \| \hat{y}^{\text{train}} - y^{\text{train}} \|_2^2$$

For convenience, we will usually omit the variable descriptor train when describing training.



MSE minimized when gradient is zero

$$\nabla_{w} MSE = 0$$

$$\nabla_{w} \frac{1}{m} \|\hat{y} - y\|_{2}^{2} = 0$$

$$\nabla_{w} \|\hat{y} - y\|_{2}^{2} = 0$$

$$\nabla_{w} \|Xw - y\|_{2}^{2} = 0 \text{ as } Xw = \hat{y}$$



 $\nabla_{w} \|Xw - y\|_{2}^{2} = 0$ $\nabla_{w}(Xw-y)^{T}(Xw-y)=0$ L_{2}^{2} norm in matrix notation $\nabla_{w}((Xw)^{T}-y^{T})(Xw-y)=0$ transpose distributive over addition $\nabla_{w} \left(w^{T} X^{T} - y^{T} \right) \left(X w - y \right) = 0$ as $(AB)^{T} = B^{T} A^{T}$ Goodfellow et al. eqn 2.9 $\nabla_{w} \left(w^{T} X^{T} X w - w^{T} X^{T} y - y^{T} X w + y^{T} y \right) = 0$ $\nabla_{w} (w^{T} X^{T} X w - y^{T} X w - y^{T} X w + y^{T} y) = 0$ as $w^{T} X^{T} y = y^{T} (w^{T} X^{T})^{T} = y^{T} X w$ $\nabla_{w} \left(w^{T} X^{T} X w - 2 y^{T} X w + y^{T} y \right) = 0$



$$\nabla_{w} \left(w^{T} X^{T} X w - 2 y^{T} X w + y^{T} y \right) = 0$$

$$\nabla_{w} \left(w^{T} X^{T} X w - 2 y^{T} X w \right) = 0$$
 as $y^{T} y$ independent of w

$$\nabla_{w} \left(X^{T} X w^{2} - 2 y^{T} X w \right) = 0$$
 as $w^{T} X^{T} X = X^{T} X w$

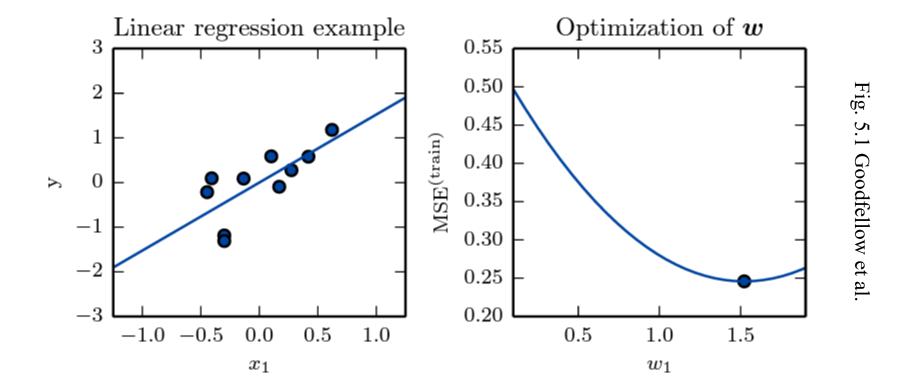
$$2X^{T} X w - 2 y^{T} X = 0$$
 derivative

$$X^{T} X w = y^{T} X$$

$$w = \left(X^{T} X \right)^{-1} y^{T} X$$
 matrix inverse $A^{-1} A = I$

These are referred to as the normal equations







Normal equations optimize w

Regression formula forces curve to pass through origin Remove restriction:

- Add bias term $\hat{y} = w^T x + b$
- To use normal equations, use modified *x*
- Last term of new weight x_{mod} vector w is bias

$$d = \begin{vmatrix} x_1 \\ x_2 \\ \vdots \\ x_D \\ 1 \end{vmatrix}$$

 $\begin{bmatrix} x \end{bmatrix}$



Notes on learning

- A learner that performs well on unseen data is said to *generalize* well.
- When will learning on training data produce good generalization?
 - Training and test data drawn from the same distribution
 - Large enough training set to learn the distribution



Underfitting & Overfitting

• Underfit Model cannot learn training data well

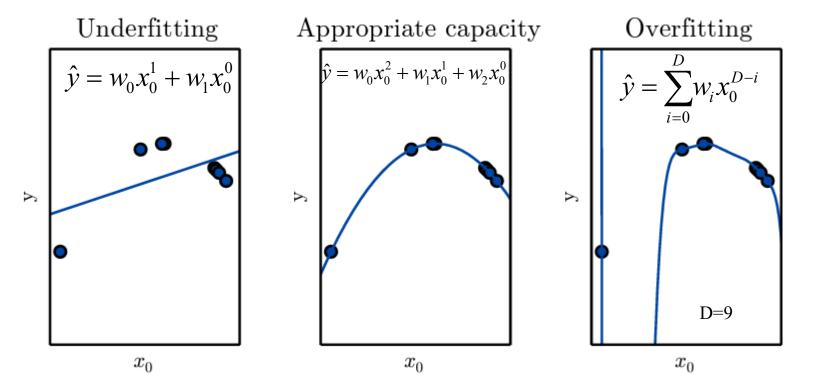
 Overfit Model does not generalize well

• These properties are related to model *capacity*



Capacity

What kind of functions can we learn?

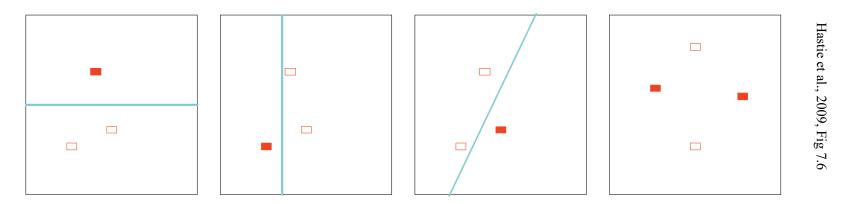




Here, model order affects capacity

Shattering points

Points are *shattered* if a classifier can separate them regardless of their binary label



We can shatter the three points, but not four with a linear classifier



Capacity

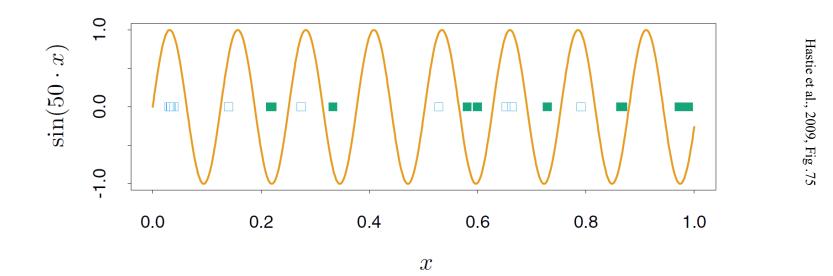
• Representational capacity – best function that can be learned within a set of learnable functions

- Frequently a difficult optimization problem
 - We might learn a suboptimal solution
 - This is called *effective capacity*



Measuring capacity

• Model order is not always a good predictor of capacity





Label determined by sign of function. Increasing frequency of sinusoid enables ever finer distinctions...

Measuring capacity

- Vapnik Chervonikis (VC) dimension
 - for binary classifiers
 - Largest # of points that can be shattered by a family of classifiers.
- In practice, hard to estimate for deep learners... so why do we care?

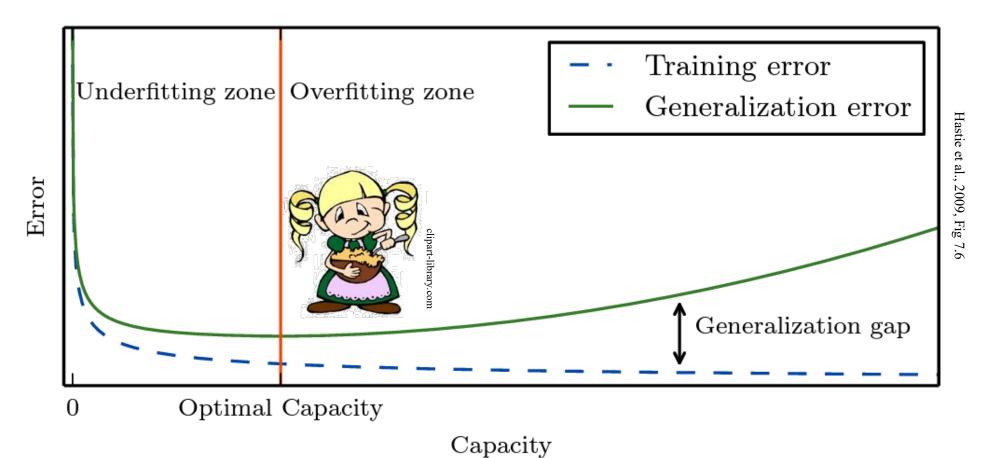


Predictions about capacity

- Goal: Minimize the generalization error
- Hard; perhaps minimize difference Δ $\Delta = |$ training error - generalization error|
- Learning theory
 - Models with higher capacity have higher upper bound on Δ
 - Increasing amount of training data decreases Δ 's upper bound



Recap on capacity





The NO FREE LUNCH Theorem

Expected performance of *any* classifier across all possible generalization tasks is no better than any other classifier.

A classifier might be better for some tasks, but no classifier is universally better than others.



http://elsalvavidas.mx/lifehacking/ inicia-tu-aventura-para-estudiar-en-el-extranjero-con-estos-tips/1182/



N-fold cross validation

• Problem:

- More data yields better training
- Getting more data can be expensive
- Workaround
 - Partition data into N different groups
 - Train on N-1 groups, test on last group
 - Rotate to have N different evaluations



Regularization

- Remember: Learners select a solution function from a set of hypothesis functions.
- Optimization picks the function that minimizes some optimization criterion
- Regularization lets us express a preference for certain types of solutions



Example: High Dimensional Polynomial Fit

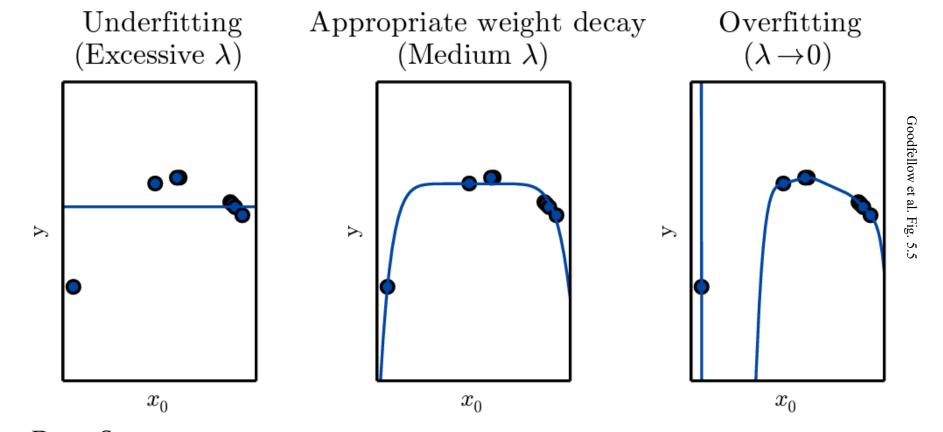
- Suppose we want small coefficients Remember: $\hat{y} = w^T x$
- This happens when $\Omega(w) = w^T w$ is small and results in shallower slopes
- We can define a new criterion:

$$J(w) = MSE + \lambda \Omega(w) = MSE + \lambda w^{T} w$$

where λ controls regularization influence



9th degree polynomial fit with regularization





Point estimators

- An approximation of interest
- Examples:
 - a statistic of a distribution

e.g.
$$\hat{\mu} = \frac{1}{N} \sum_{i} x^{(i)}$$
 is an approximation of μ

- a parameter of a classifier
 - e.g. a mixture model weight or distribution parameter



Point estimators

In general, it is a function of data

$$\hat{\Theta}_m = f(x^{(1)}, x^{(2)}, x^{(3)}, \dots, x^{(m)})$$

and may even be a classifier function that maps data to a label (*function estimation*).



Bias

How far from the true value is our estimator?

$$\operatorname{bias}(\hat{\theta}_m) = E[\hat{\theta}_m] - \theta$$

Goodfellow et al. give an example with a Bernoulli distribution that we have not yet covered (read 3.9.1). Bernoulli distributions are good for estimating the number of times that a binary event occurs (e.g., 42 head in 100 coin tosses).



Bias of sample mean bias $(\hat{\mu}_m) = E[\hat{\mu}_m] - \mu$ $= E \left| \frac{1}{N} \sum_{i} x^{(i)} \right| - \mu$ $=\frac{1}{N}E\left|\sum_{i}x^{(i)}\right|-\mu$ $= \frac{1}{N} N \cdot E[X] - \mu \quad x^{(i)} \text{ is a random var}$ $= \mu - \mu = 0$ unbiased estimator



Bias

- Read more examples in Goodfellow et al.
- Bias of classifier functions?
 - We are trying to estimate the Bayes classifier.
 - Bias is amount of error over that



Variance

- Already defined: $Var(X) = E[(X \mu)^2]$
- Variance of classifier functions
 - Variance of a mean classification result, e.g., error rate $Var(\hat{\mu}_{m}) = Var\left(\frac{1}{m}(X_{1} + X_{2} + ... + X_{m})\right)$ $= \frac{1}{m^{2}}Var(X_{1} + X_{2} + ... + X_{m}) \text{ as } Var(kX) = k^{2}Var(X)^{\dagger}$ $= \frac{1}{m^{2}}m\sigma^{2} = \frac{1}{m}\sigma^{2} \text{ or equivalantly, standard error } SE(\hat{\mu}_{m}) = \frac{\sigma}{\sqrt{m}}$



[†] it can be shown that $Var(X) = E[X^2] - E[X]^2$, $Var(kX) = k^2 Var(X)$ follows from this

Bias & Variance

- Variance gives us an idea of classifier sensitivity to different data
- Distribution of mean approaches a normal distribution (central limit theorem)
- Together can estimate with 95% confidence that the real mean lies within:

$$\hat{\mu}_m - 1.96SE(\hat{\mu}_m) \le \mu_m \le \hat{\mu}_m + 1.96SE(\hat{\mu}_m)$$



Information Theory

A quick trip down the rabbit hole...

- Details in Goodfellow
- Needed for maximum likelihood estimators

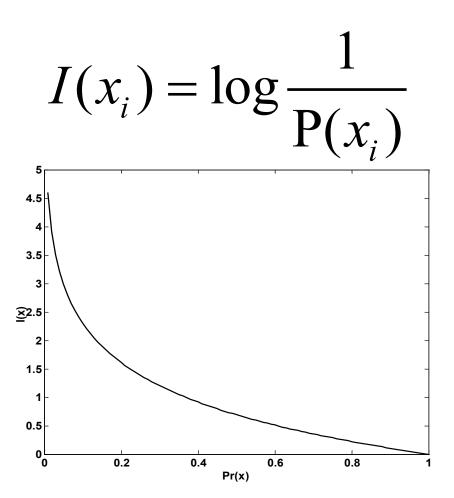


British Postal Service, Graham Baker-Smith 2015



Quantity of information

- Amount of surprise that one sees when observing an event.
- If an event is rare, we can derive a large quantity of information from it.





Quantity of information

- Why use log?
 - Suppose we want to know the information in two independent events:

$$I(x_{1}, x_{2}) = \log \frac{1}{P(x_{1}, x_{2})}$$

= $\log \frac{1}{P(x_{1})P(x_{2})}$ x_{1}, x_{2} independent
= $\log \frac{1}{P(x_{1})} + \log \frac{1}{P(x_{2})}$
= $I(x_{1}) + I(x_{2})$



Entropy

• Entropy is defined as the expected amount of information (average amount of surprise) and is usually denoted by the symbol H.

$$H(X) = E[I(X)]$$

= $\sum_{x_i \in S} P(x_i)I(x_i)$ S is all possible symbols
= $\sum_{x_i \in S} P(x_i)\log\frac{1}{P(x_i)}$ definition $I(x_i)$
= $E[-\log P(X)]$



Discrete vs continuous

Discrete

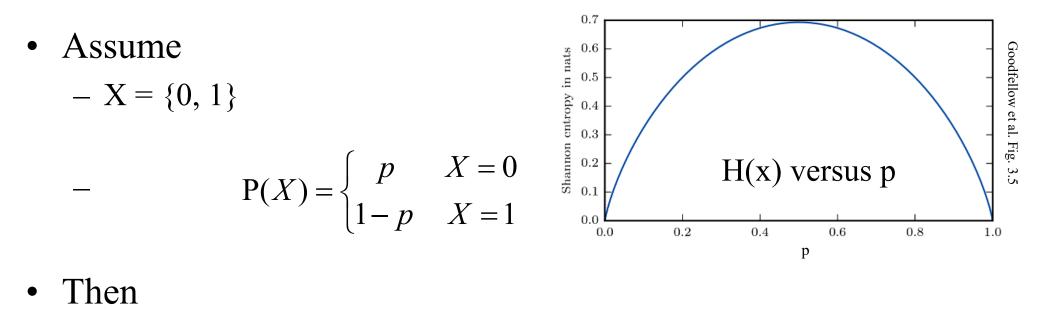
- Shannon Entropy
- Use \log_2
- Units called
 - bits, or sometimes
 - Shannons

Continuous

- Differential entropy
- Use \log_{e}
- Units called nats



Example



$$H(X) = E[I(X)]$$

= $-p \log p - (1-p) \log(1-p)$



Comparing distributions

- How similar are distributions P and Q? Recall
 - X~P means that X has distribution P
 - we denote its probability as P_P and information as I_P
- How much more information do we need to represent P's distribution using Q:

$$E_{X \sim P} [I_Q - I_P] = E_{X \sim P} [-\log P_Q - (-\log P_P)]$$
$$= E_{X \sim P} \left[\log \frac{P_P}{P_Q}\right]$$
$$= \sum_x P_P (x) \log \frac{P_P(x)}{P_Q(x)}$$



Comparing distributions

• This is known as the Kullback-Leibler (KL) divergence from Q to P:

$$D_{KL}(P||Q) = E_{X \sim P} \left[\log \frac{P_P(X)}{P_Q(X)} \right] = E_{X \sim P} \left[-\log P_Q(X) + \log P_P(X) \right]$$

 $D_{KL}(P \parallel Q) = 0$ iff $P \equiv Q$, otherwise $D_{KL}(P \parallel Q) > 0$

note: $D_{KL}(P||Q) \neq D_{KL}(Q||P) \rightarrow$ not a distance measure



Cross entropy H(P,Q)

- Calculates total entropy in two distributions $H(P,Q) = E_{X \sim P} \left[-\log P_Q(X) \right]$
- Can be shown to have the entropy of P plus the KL divergence from Q to P.

 $H(P,Q) = H(P) + D_{KL}(P||Q)$

• Interesting as we sometimes want to minimize KL divergence...



Cross entropy

Minimizing the KL divergence minimizes the cross entropy:

$$H(P,Q) = E_{X \sim P} \left[-\log P_Q(X) \right] = H(P) + D_{KL}(P||Q)$$

= $H(P) + E_{X \sim P} \left[\log P_P(X) - \log P_Q(X) \right]$
= $-E_{X \sim P} \left[\log P_P(X) \right] + E_{X \sim P} \left[\log P_P(X) \right] + E_{X \sim P} \left[-\log P_Q(X) \right]$
= $E_{X \sim P} \left[-\log P_Q(X) \right]$

Suggests that if we are trying to fit a distribution to data, minimizing the cross entropy H(ActualDist, ModelDist) may be appropriate.



Maximum Likelihood Estimation (MLE)

- Method to estimate model parameters
- Suppose we have *m* independent samples drawn from a distribution
- Can we fit a model with parameters Θ ?

 $\mathbf{X} = \{x^{(1)}, x^{(2)}, \dots, x^{(m)}\}\$ $\theta_{ML} = \arg\max_{\theta} P(\mathbf{X} \mid \theta)$



MLE

• The x⁽ⁱ⁾'s are independent, so

 $\theta_{ML} = \arg \max_{\theta} P(\mathbf{X} \mid \theta) = \arg \max_{\theta} \prod_{i} P(x^{(i)} \mid \theta)$

• Log transform for numerical stability

$$\theta_{ML} = \arg \max_{\theta} \prod_{i} P(x^{(i)} | \theta) = \arg \max_{\theta} \sum_{i} \log P(x^{(i)} | \theta)$$

• Traditional to use derivatives and solve for the maximum value.



MLE through optimization

• Let us reframe this problem:

$$\theta_{ML} = \arg \max_{\theta} \sum_{i} \log P_{model} (x^{(i)} | \theta)$$

= $\arg \max_{\theta} E_{X \sim \hat{P}_{data}} [\log P_{model} (x | \theta)]$ Why can we think of this as $E[\cdot]$?

- Maximized when P_{model} is most like \hat{P}_{data}
- What does this remind us of?



MLE through optimization

- $D_{KL}(\hat{P}_{data}||P_{model})$ minimized as P_{model} becomes more like \hat{P}_{data}
- Recall

$$D_{KL}(\hat{P}_{data}||P_{model}) = E_{X \sim \hat{P}_{data}} \left[\log \hat{P}_{data}(X) - \log P_{model}(X) \right]$$

• $E_{X \sim \hat{P}_{data}}[\log \hat{P}_{data}(X)]$ constant with the same X, so we only need minimize the second term

 $-E_{X \sim \hat{P}_{data}}[\log P_{model}(X)]$



MLE through optimization

- We now have a good framework to estimate a model Θ even when do not have a good parametric model
- We know that we can maximize the likelihood of the data with respect to model Θ by minimizing the cross entropy between the data and model



- Instead of thinking of predicting value $\hat{y} = wx$, what if we predicted a conditional probability? $P(\hat{y}|x,\Theta)$
- Regression: only one possible output.
- MLE estimates a distribution: support for multiple outcomes, can think of this as a noisy prediction.



Theory behind conditional log-likelihood & its relationship to mean squared error will not be tested

- Assume $Y|X \sim n(\mu, \sigma^2)$
 - learn μ such that $E[Y | x^{(i)}] = y^{(i)}$ - σ^2 fixed (noise)
 - $-\sigma^2 \operatorname{fixed}(\operatorname{noise})$
- Can formulate as an MLE problem

 $\theta_{\rm ML} = \arg \max_{\theta} P(Y \mid X; \theta)$

where parameter Θ is our weights *w*.



 $\begin{aligned} \theta_{\text{ML}} &= \arg \max_{\theta} P(Y|X;\theta) \\ &= \arg \max_{\theta} \prod_{i} P(y^{(i)}|x^{(i)};\theta) \quad \text{if } x^{(i)'} \text{s independent \& identically distributed} \end{aligned}$

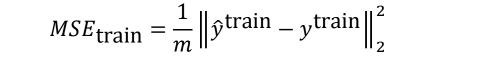
$$\log \theta_{\text{ML}} = \arg \max_{\theta} \sum_{i} \log P(y^{(i)} | x^{(i)}; \theta)$$

= $\arg \max_{\theta} \sum_{i} \log \frac{1}{\sqrt{2\pi\sigma^2}} e^{\frac{-(\hat{y}^{(i)} - \mu)^2}{2\sigma^2}} \text{ prediction of } y^{(i)} \text{ is } \hat{y}^{(i)}$
= $\arg \max_{\theta} \sum_{i} \log \frac{1}{\sqrt{2\pi\sigma^2}} e^{\frac{-(\hat{y}^{(i)} - y^{(i)})^2}{2\sigma^2}} \text{ as we want } E[Y|x^{(i)}] = y^{(i)}$



$$\log \theta_{\text{ML}} = \arg \max_{\theta} \sum_{i} \log \frac{1}{\sqrt{2\pi\sigma^{2}}} e^{\frac{-(\hat{y}^{(i)} - y^{(i)})^{2}}{2\sigma^{2}}}$$
$$= \arg \max_{\theta} \sum_{i} \left(-\frac{1}{2} \log(2\pi) - \log \sigma - \frac{(\hat{y}^{(i)} - y^{(i)})^{2}}{2\sigma^{2}} \right)$$
$$= \arg \max_{\theta} \left(-\frac{m}{2} \log(2\pi) - m \log \sigma - \sum_{i} \frac{(\hat{y}^{(i)} - y^{(i)})^{2}}{2\sigma^{2}} \right)$$
$$= \arg \max_{\theta} \left(-\sum_{i} (\hat{y}^{(i)} - y^{(i)})^{2} \right) \text{ as } \sigma \text{ is constant}$$

Equivalent to maximizing $\sum_{i} (\hat{y}^{(i)} - y^{(i)})^2$ which has the same form as or MSE optimization:





MLE limitations

- MLE can only recover the distribution if the parametric distribution is appropriate for the data.
- If data drawn from multiple distributions with varying parameters, MLE can still estimate distribution, but information about underlying distributions is lost.



Optimization

• We have seen closed form (single equation) optimization with linear regression.

• Not always so lucky... how do we optimize more complicated things?



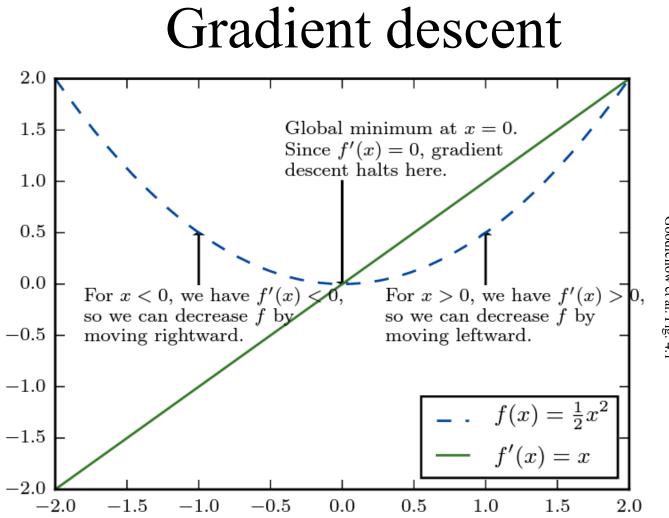
Optimization

Select an *objective* function *f(x)* to optimize
e.g. MSE, KL divergence

• Without loss of generality, we will always consider minimization.

Why can we do this?

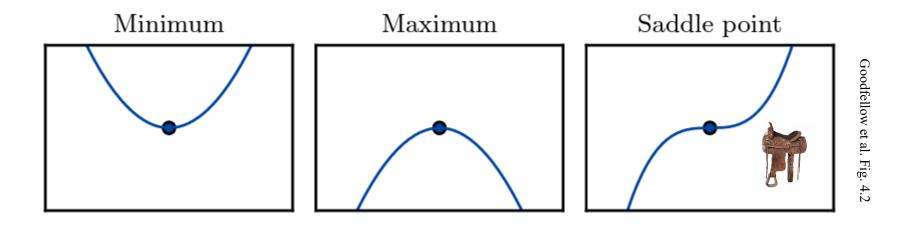






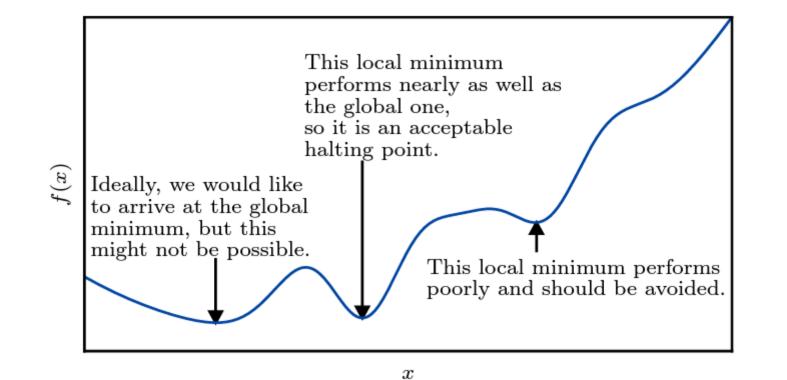


Critical points





Global vs. local minima





Goodfellow et al. Fig. 4.3

Functions on $\mathbb{R}^m \to \mathbb{R}^1$

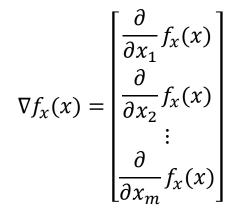
• Gradient vector of partial derivatives

- Moving in gradient direction will increase f(x) if we don't go too far...
- To move to an x with a smaller f(x)

 $x' = x - \epsilon \nabla f_x(x)$

what we pick for ε will make a difference

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IMPORTANT: f is loss fn to be optimized, e.g. MSE, not learner

Putting this all together

note change in notation, objective is J()

- Want to learn: $f_{\theta}(\mathbf{x}_i) = y_i$
- To improve $f_{\theta}(\mathbf{x}_i)$, define objective $J(\theta)$
- Optimize $J(\Theta)$
 - Gradients defined for each sample
 - Average over data set (e.g. mini-batch) and update Θ



Putting this all together

• Sample $J(\Theta)$, a loss function:

$$J(\theta) = E_{x,y \sim \hat{p}_{data}}[L(x,y,\theta)] = \frac{1}{m} \sum_{i=1}^{m} L(x^{(i)}, y^{(i)}, \theta)$$

where $L(x,y,\theta) = -\log P(y|x,\theta)$ remember D_{KL} ?
implies $J(\theta) = \frac{1}{m} \sum_{i=1}^{m} -\log P(y|x,\theta)$

• which is like our effort to get a MLE by minimizing KL divergence:

$$H(P||Q) = E_{X \sim P}\left[-\log P_Q(X)\right] = E_{X \sim P}\left[-\log P_Q(X)\right]$$



Loss (aka cost) is a measurement of how far we are from the desired result.



"There's the rub"

Shakespeare's Hamlet

 Computing J(Θ) is expensive
 One example not so bad... massive data sets...



- Sample expectation relies on having enough samples that the 1/*m* term estimates P(X).
- What if we only evaluated some of them...



Stochastic gradient descent (SGD)

while not converged: pick minibatch of samples (x,y) compute gradient update estimate

minibatch is usually up to a 100 samples

